

650V N-Channel Super-Junction MOSFET

Features

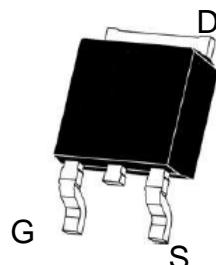
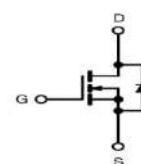
- Super-Junction MOSFET
- Low ON Resistance
- Improved dv/dt Capability
- 100% Avalanche Tested
- RoHS compliant

Product Summary

V_{DS}	650	V
$R_{DS(on),TYP} @ V_{GS}=10\text{ V}$	850	$\text{m}\Omega$
I_D	4	A

Applications

- Switching Mode Power Supplies (SMPS)
- PWM Motor Controls
- LED Lighting
- Adapter


TO-252 top view

Schematic diagram
ABSOLUTE MAXIMUM RATINGS ($T_C = 25^\circ\text{C}$, unless otherwise noted)

Parameter	Symbol	Limit	Unit
Drain to Source Voltage	V_{DSS}	650	V
Continuous Drain Current (@ $T_C=25^\circ\text{C}$)	I_D	4 (1)	A
Continuous Drain Current (@ $T_C=100^\circ\text{C}$)		4.2 (1)	A
Drain current pulsed (2)	I_{DM}	16 (1)	A
Gate to Source Voltage	V_{GS}	± 30	V
Single pulsed Avalanche Energy (3)	E_{AS}	67.5	mJ
MOSFET dv/dt Ruggedness($V_{DS}=0\text{~}400\text{ V}$)	dv/dt	40	V/ns
Peak diode Recovery dv/dt (4)	dv/dt	15	V/ns
Total power dissipation (@ $T_C=25^\circ\text{C}$)	P_D	38	W
Derating Factor above 25°C		0.3	W/ $^\circ\text{C}$
Operating Junction Temperature & Storage Temperature	T_{STG}, T_J	-55 to + 150	$^\circ\text{C}$
Maximum lead temperature for soldering purpose	T_L	260	$^\circ\text{C}$

Notes

1. Drain current is limited by maximum junction temperature.
2. Repetitive rating : pulse width limited by junction temperature.
- 3 . L = 60mH, $I_{AS} = 1.5\text{ A}$, $V_{DD} = 50\text{ V}$, $R_G=25\Omega$, Starting at $T_J = 25^\circ\text{C}$
4. $I_{SD} \leq I_D$, $di/dt = 100\text{ A/us}$, $V_{DD} \leq 400\text{ V}$, Starting at $T_J = 25^\circ\text{C}$

THERMAL CHARACTERISTICS

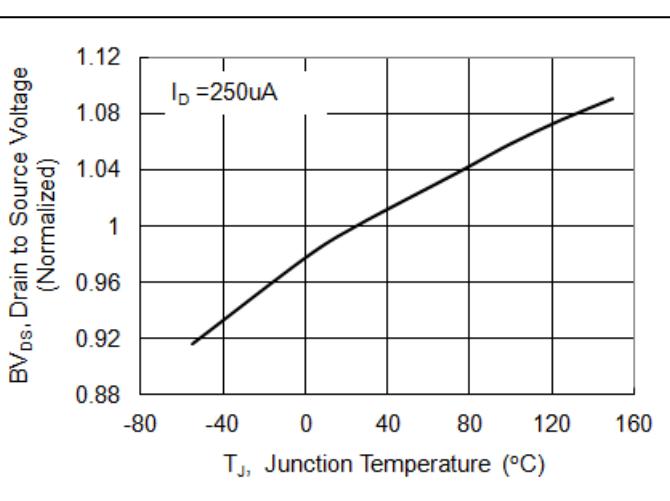
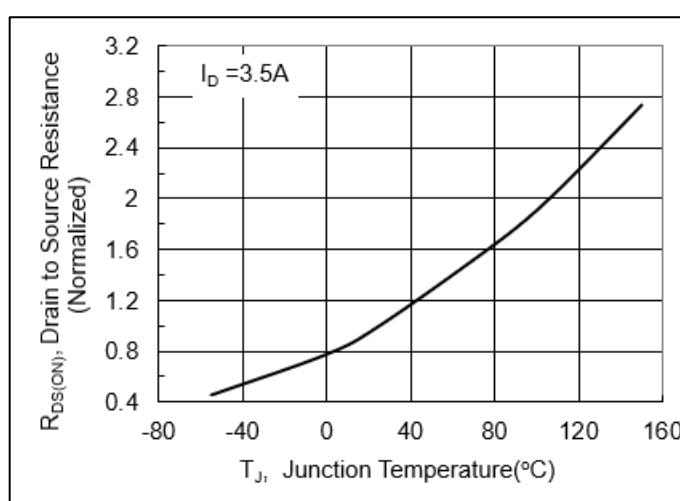
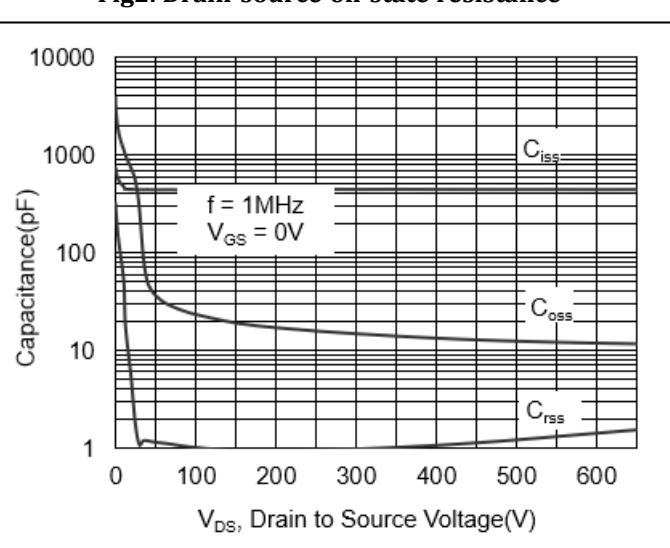
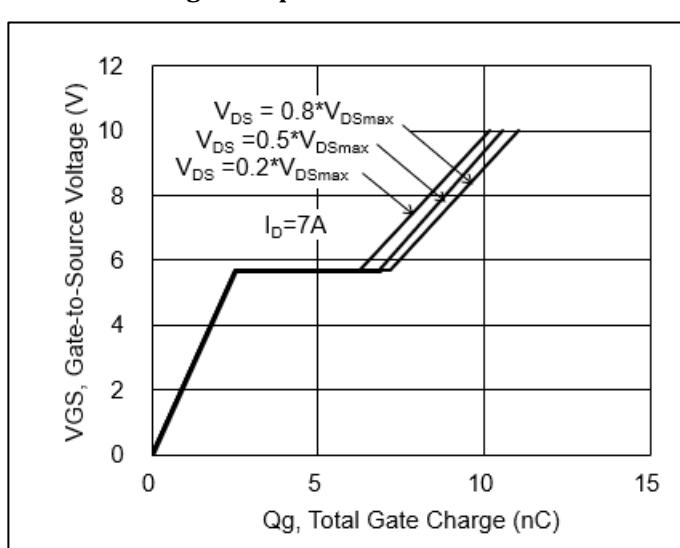
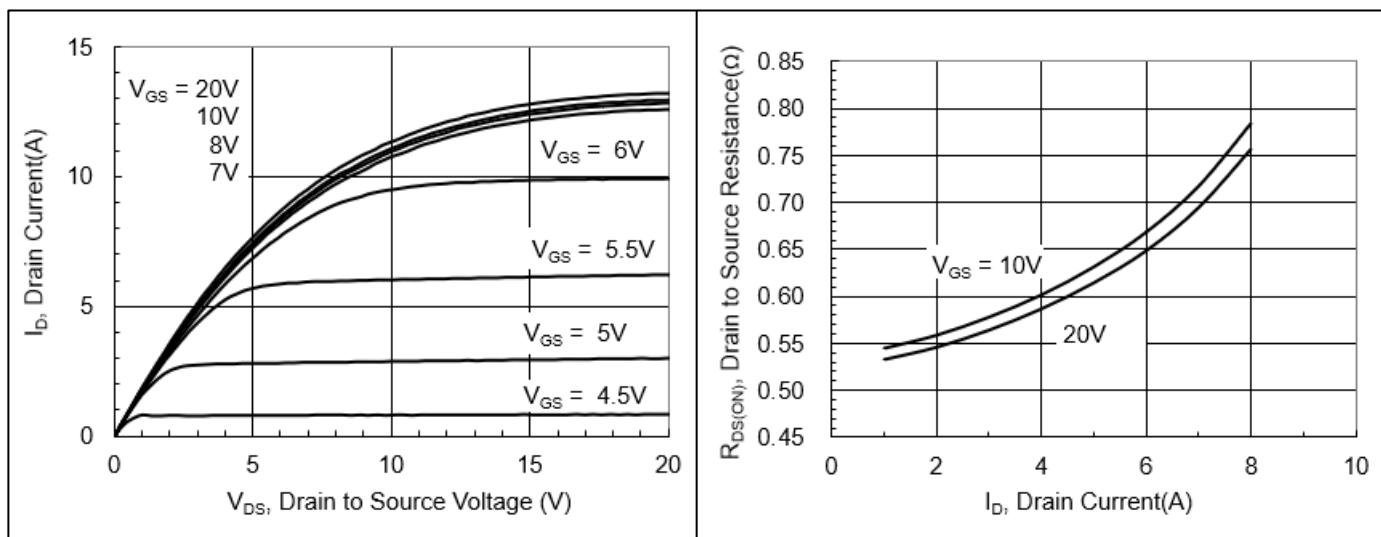
Parameter	Symbol	Value	Unit
Thermal resistance, Junction to case (Maximum)	R_{thjc}	3.3	$^\circ\text{C/W}$
Thermal resistance, Junction to ambient (Maximum)	R_{thja}	67	$^\circ\text{C/W}$

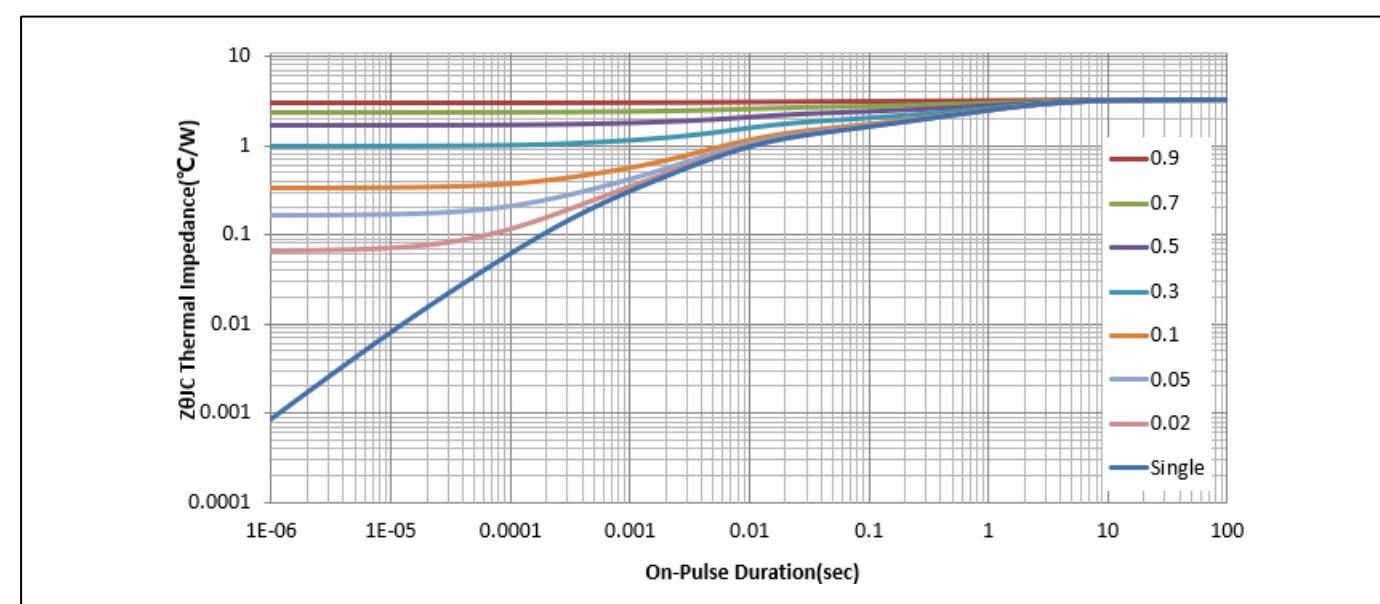
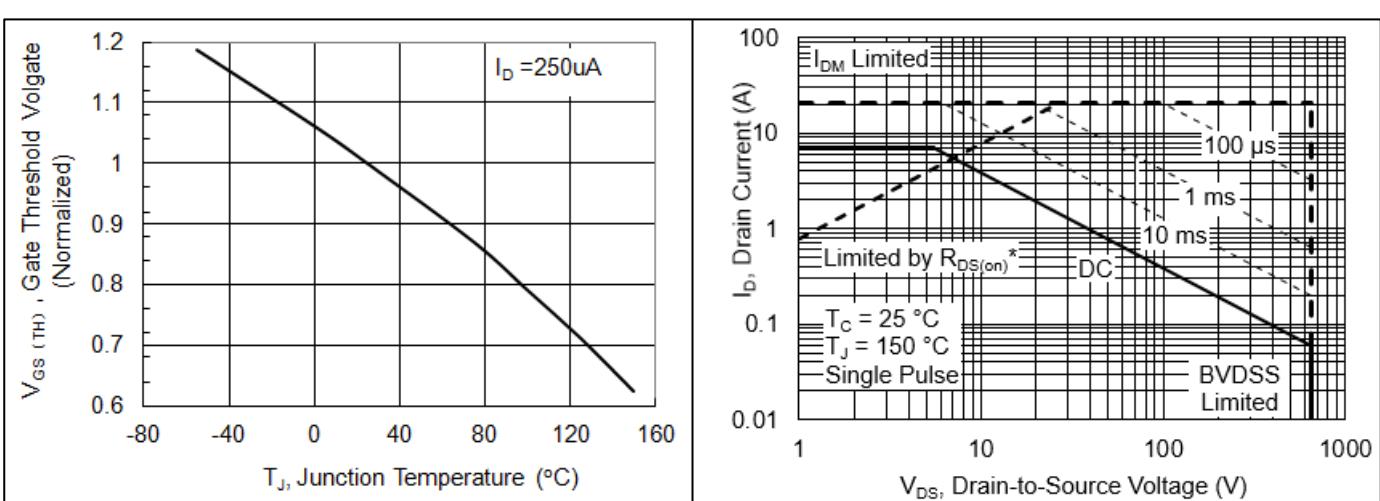
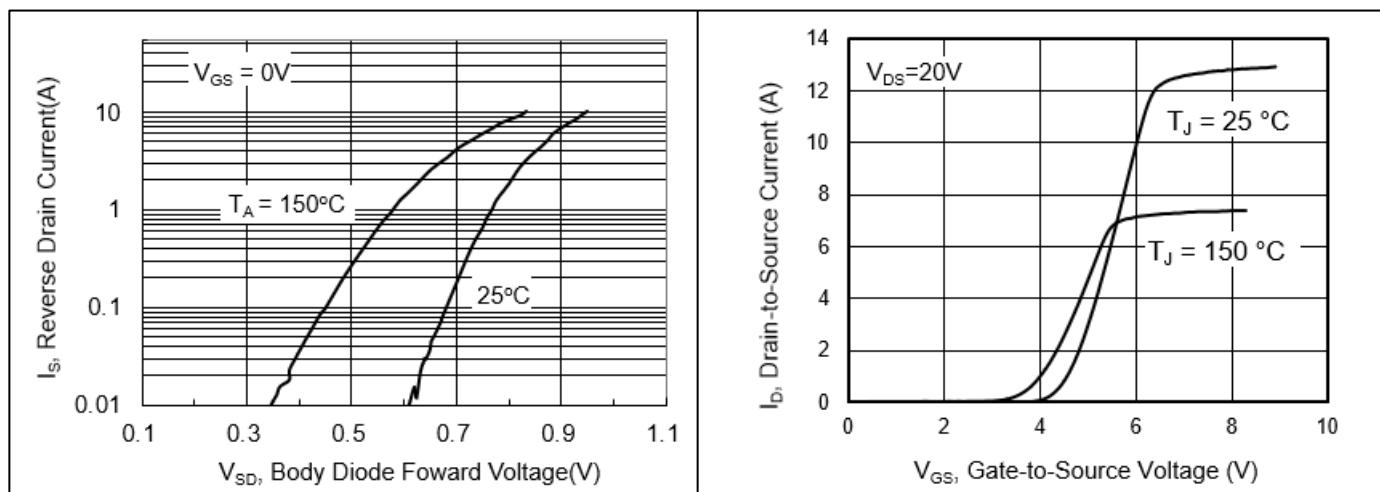
650V N-Channel Super-Junction MOSFET
ELECTRICAL CHARACTERISTICS ($T_C = 25^\circ\text{C}$ unless otherwise specified)

Parameter	Symbol	Test conditions	Min.	Typ.	Max.	Unit
Off Characteristics						
Drain to source breakdown voltage	BV_{DSS}	$V_{\text{GS}}=0\text{V}, I_{\text{D}}=250\mu\text{A}$	650	--	--	V
Breakdown voltage temperature coefficient	$\Delta \text{BV}_{\text{DSS}} / \Delta T_J$	$I_{\text{D}}=250\mu\text{A}$, referenced to 25°C	--	0.7	--	$\text{V}/^\circ\text{C}$
Drain to source leakage current	I_{DSS}	$V_{\text{DS}}=650\text{V}, V_{\text{GS}}=0\text{V}$ $V_{\text{DS}}=520\text{V}, T_C=125^\circ\text{C}$	--	--	1	μA
Gate to source leakage current, forward	I_{GSS}	$V_{\text{GS}}=30\text{V}, V_{\text{DS}}=0\text{V}$	--	--	100	nA
Gate to source leakage current, reverse		$V_{\text{GS}}=-30\text{V}, V_{\text{DS}}=0\text{V}$	--	--	-100	nA
On Characteristics						
Gate threshold voltage	$V_{\text{GS(TH)}}$	$V_{\text{DS}}=V_{\text{GS}}, I_{\text{D}}=250\mu\text{A}$	2.0	3.0	4.0	V
Drain to source on state resistance	$R_{\text{DS(ON)}}$	$V_{\text{GS}}=10\text{V}, I_{\text{D}}=2.5\text{A}$	--	850	900	$\text{m}\Omega$
Forward Transconductance	G_{fs}	$V_{\text{DS}}=10\text{V}, I_{\text{D}}=2.5\text{A}$	--	5.8	--	S
Dynamic Characteristics						
Input capacitance	C_{iss}	$V_{\text{GS}}=0\text{V}, V_{\text{DS}}=100\text{V}, f=1\text{MHz}$	--	312	--	pF
Output capacitance	C_{oss}		--	12	--	
Reverse transfer capacitance	C_{rss}		--	2	--	
Turn on delay time	$t_{\text{d(on)}}$	$V_{\text{DS}}=350\text{V}, I_{\text{D}}=4\text{A}$, $R_G=25\Omega, V_{\text{GS}}=10\text{V}$	--	9	--	ns
Rising time	t_{r}		--	9	--	
Turn off delay time	$t_{\text{d(off)}}$		--	23	--	
Fall time	t_{f}		--	81	--	
Total gate charge	Q_g	$V_{\text{DS}}=350\text{V}, V_{\text{GS}}=10\text{V}, I_{\text{D}}=4\text{A}$	--	7.6	--	nC
Gate-source charge	Q_{gs}		--	2.1	--	
Gate-drain charge	Q_{gd}		--	2.4	--	
Gate Resistance	R_g	$V_{\text{DS}}=0\text{V}$, Scan F mode	--	15	--	Ω

SOURCE TO DRAIN DIODE RATINGS CHARACTERISTICS

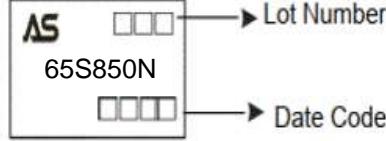
Parameter	Symbol	Test conditions	Min.	Typ.	Max.	Unit
Continuous source current	I_s	Integral reverse p-n Junction diode in the MOSFET	--	--	4	A
Pulsed source current	I_{SM}		--	--	16	A
Diode forward voltage drop.	V_{SD}	$I_s=4\text{A}, V_{\text{GS}}=0\text{V}$	--	--	1.4	V
Reverse recovery time	T_{rr}	$I_s=4\text{A}, V_{\text{GS}}=0\text{V}$, $dI/dt=100\text{A/us}$	--	131	--	ns
Reverse recovery Charge	Q_{rr}		--	632	--	nC

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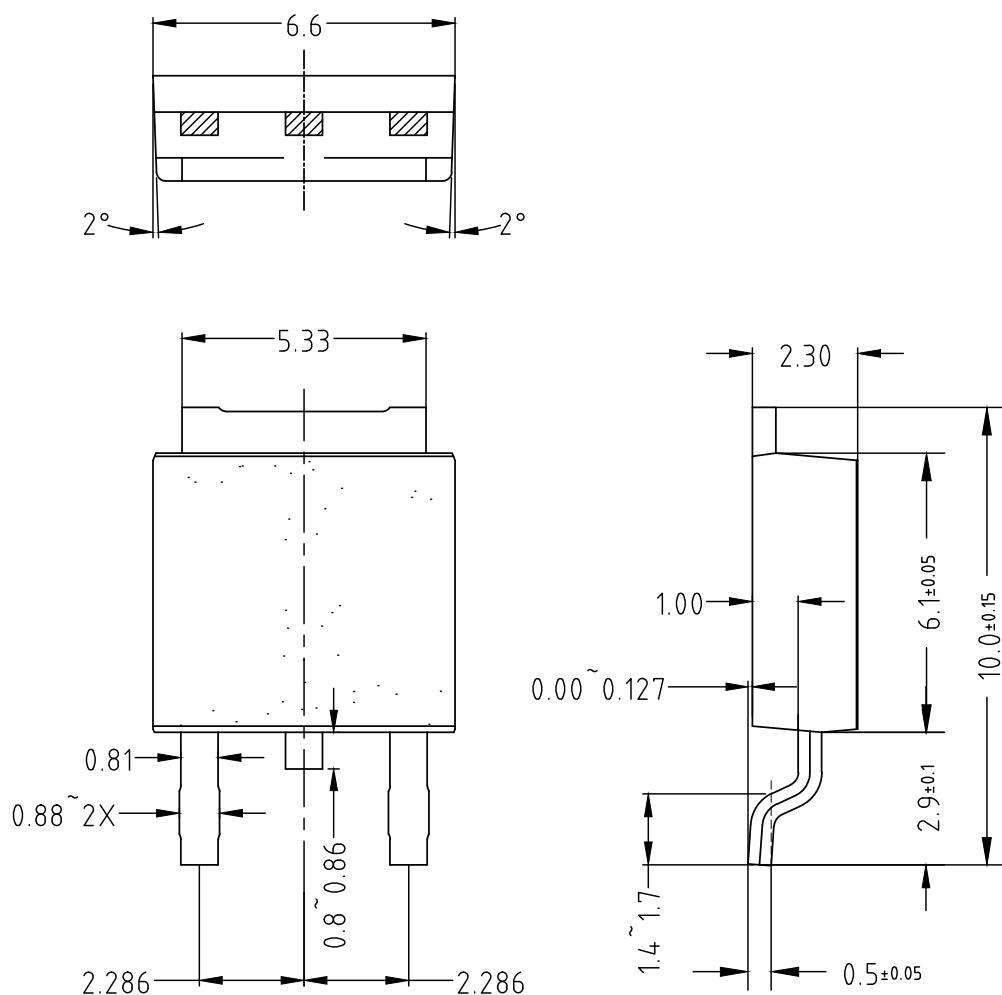
Ordering and Marking Information

Ordering Device No.	Marking	Package	Packing	Quantity
ASDM65S850NKQ-R	65S850N	TO-252	Tape&Reel	2500/Reel

PACKAGE	MARKING
TO-252	

650V N-Channel Super-Junction MOSFET

TO-252



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